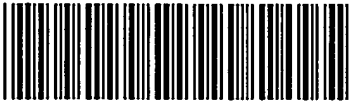


**Search Notes**

Application/Control No.

10/808,509

Examiner

David J. Makiya

Applicant(s)/Patent under  
Reexamination

ISHII ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	489	12/8/2005	DJM
	23		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search in EAST attached	12/8/2005	DJM